

MOSFETs Silicon N-Channel MOS

# SSM6K403TU

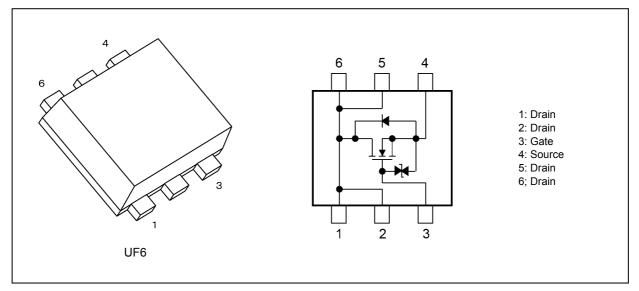
### 1. Applications

- · Power Management Switches
- · High-Speed Switching

#### 2. Features

- (1) 1.5-V drive
- (2) Low drain-source on-resistance
  - $: R_{DS(ON)} = 66 \text{ m}\Omega \text{ (max) } (@V_{GS} = 1.5 \text{ V})$ 
    - $R_{DS(ON)} = 43 \text{ m}\Omega \text{ (max) } (@V_{GS} = 1.8 \text{ V})$
  - $R_{DS(ON)} = 32 \text{ m}\Omega \text{ (max) } (@V_{GS} = 2.5 \text{ V})$
  - $R_{\mathrm{DS(ON)}} = 28~\mathrm{m}\Omega~(\mathrm{max})~(@V_{\mathrm{GS}} = 4.0~\mathrm{V})$

### 3. Packaging and Internal Circuit



Start of commercial production



### 4. Absolute Maximum Ratings (Note) (Unless otherwise specified, Ta = 25 °C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		$V_{DSS}$	20	V
Gate-source voltage		$V_{GSS}$	±10	
Drain current (DC)	(Note 1)	I <sub>D</sub>	4.2	Α
Drain current (pulsed)	(Note 1), (Note 2)	I <sub>DP</sub>	8.4	
Power dissipation	(Note 3)	$P_{D}$	500	mW
Channel temperature		T <sub>ch</sub>	150	°C
Storage temperature		T <sub>stg</sub>	-55 to 150	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- Note 1: Ensure that the channel temperature does not exceed 150 °C.
- Note 2: Pulse width (PW)  $\leq$  10 ms, duty  $\leq$  1%
- Note 3: Device mounted on an FR4 board. (25.4 mm × 25.4 mm × 1.6 mm ,Cu pad: 645 mm<sup>2</sup>)

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance,  $R_{th(ch-a)}$ , and the drain power dissipation,  $P_D$ , vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.



#### 5. Electrical Characteristics

### 5.1. Static Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain-source breakdown voltage		V <sub>(BR)DSS</sub>	$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	20	_	_	V
Drain-source breakdown voltage		V <sub>(BR)DSX</sub>	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = -10 V	12	_	_	
Drain cut-off current		I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	_	_	1	μΑ
Gate leakage current		I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 10 \text{ V}$	_	_	±1	
Gate threshold voltage	(Note 1)	$V_{th}$	$V_{DS} = 3 \text{ V}, I_{D} = 1 \text{ mA}$	0.35	_	1.0	V
Forward transfer admittance	(Note 2)	Y <sub>fs</sub>	$V_{DS} = 3 \text{ V}, I_D = 3.0 \text{ A}$	10	20		S
Drain-source on-resistance	(Note 2)	R <sub>DS(ON)</sub>	I <sub>D</sub> = 3.0 A, V <sub>GS</sub> = 4.0 V	_	19	28	mΩ
			$I_D = 3.0 \text{ A}, V_{GS} = 2.5 \text{ V}$	_	23	32	
			I <sub>D</sub> = 1.0 A, V <sub>GS</sub> = 1.8 V	_	28	43	
			I <sub>D</sub> = 0.5 A, V <sub>GS</sub> = 1.5 V	_	35	66	

Note 1: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ .

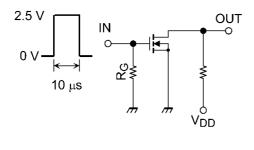
Take this into consideration when using the device.

Note 2: Pulse measurement.

### 5.2. Dynamic Characteristics (Unless otherwise specified, T<sub>a</sub> = 25 °C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	1050	_	pF
Output capacitance	Coss		_	175		
Reverse transfer capacitance	C <sub>rss</sub>		_	160		
Switching time (turn-on time)	t <sub>on</sub>	$V_{DD} = 10 \text{ V}, I_D = 1 \text{ A},$ $V_{GS} = 0 \text{ to } 2.5 \text{ V}, R_G = 4.7 \Omega,$		18		ns
Switching time (turn-off time)	t <sub>off</sub>	Duty $\leq$ 1%, Input: $t_r$ , $t_f$ < 5 ns, Common source, $T_a$ = 25 °C	_	32	_	

### 5.3. Switching Time Test Circuit



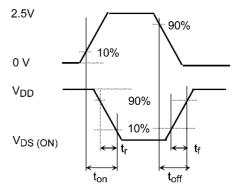


Fig. 5.3.1 Switching Time Test Circuit

Fig. 5.3.2 Input Waveform/Output Waveform



# 5.4. Gate Charge Characteristics (Unless otherwise specified, $T_a$ = 25 °C)

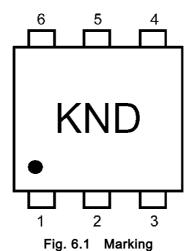
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	Qg	$V_{DD} = 10 \text{ V}, I_D = 4.2 \text{ A},$	_	16.8	_	nC
Gate-source charge	Q <sub>gs</sub>	$V_{GS} = 4 V$	_	12.1	_	
Gate-drain charge	Q <sub>gd</sub>		_	4.7	_	

## 5.5. Source-Drain Characteristics (Unless otherwise specified, Ta = 25 °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Diode forward voltage	(Note 1)	$V_{DSF}$	$I_D = -4.2 \text{ A}, V_{GS} = 0 \text{ V}$	_	-0.8	-1.2	V

Note 1: Pulse measurement.

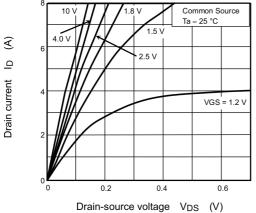
### 6. Marking

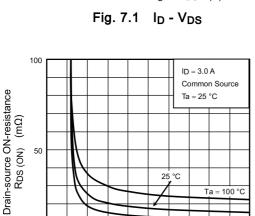


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### 7. Characteristics Curves (Note)





Gate-source voltage V<sub>GS</sub> (V) Fig. 7.3 R<sub>DS(ON)</sub> - V<sub>GS</sub>

-25 °C

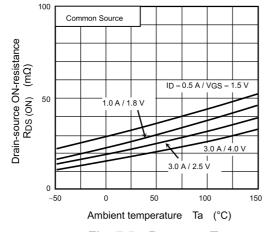


Fig. 7.5 R<sub>DS(ON)</sub> - T<sub>a</sub>

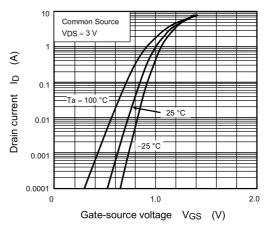


Fig. 7.2 I<sub>D</sub> - V<sub>GS</sub>

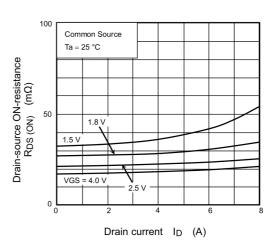


Fig. 7.4 R<sub>DS(ON)</sub> - I<sub>D</sub>

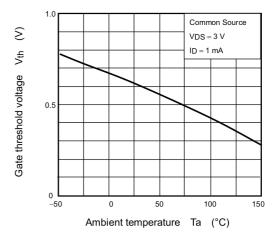
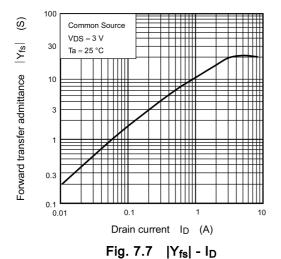
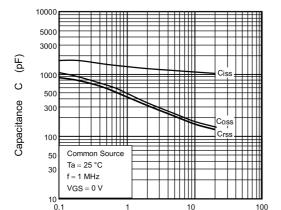
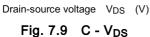


Fig. 7.6 V<sub>th</sub> - T<sub>a</sub>









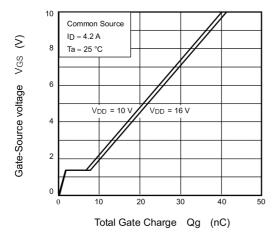


Fig. 7.11 Dynamic Input Characteristic

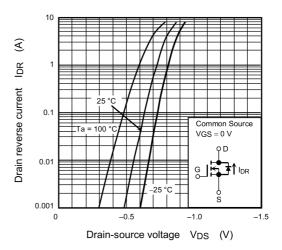


Fig. 7.8  $I_{DR}$  -  $V_{DS}$ 

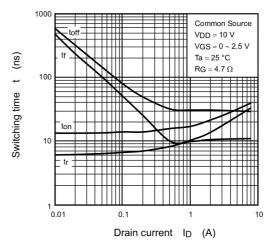


Fig. 7.10 t - I<sub>D</sub>

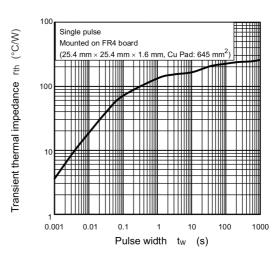
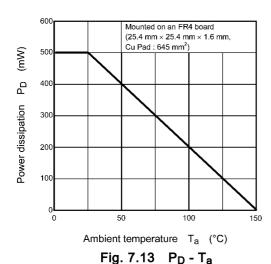


Fig. 7.12  $r_{th}$  -  $t_W$ 





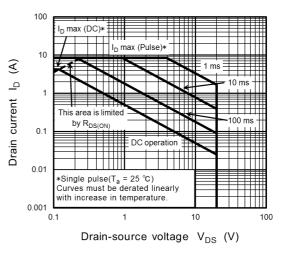


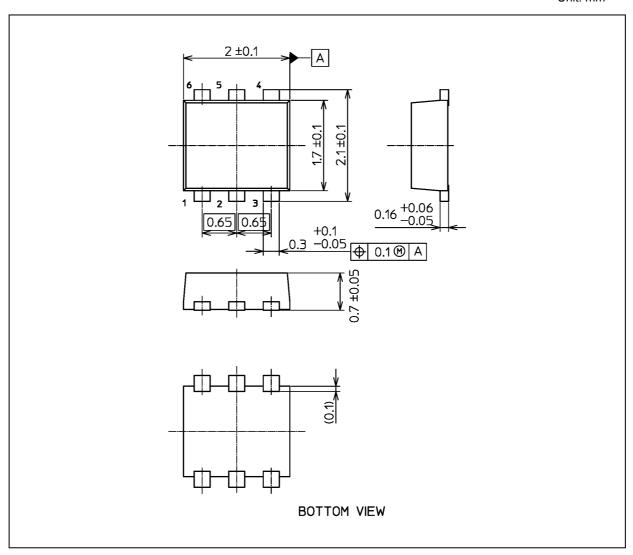
Fig. 7.14 Safe Operating Area

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



### **Package Dimensions**

Unit: mm



Weight: 7.0 mg (typ.)

	Package Name(s)	
Nickname: UF6		



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